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CERTIFICATE OF COMPLIANCE FCC Part 15.225 Certification

Applicant Name:

En-Vision America, Inc.
1845 W. Hovey Ave.
Normal, IL 61761

Date of Testing:

July 28, 2007

Test Site/Location:

PCTEST Lab, Columbia, MD, USA

Test Report Serial No.:

0706150608.VE3

FCC ID: VE3-ST51

APPLICANT: En-Vision America, Inc.

Model(s): ScripTalk Station

EUT Type: RFID Reader

Frequency Range: 13.56MHz

FCC Classification: Part 15 Low Power Communication Device Transmitter (DXX)

FCC Rule Part(s): FCC Part 15 Subpart C (15.225)

The device bearing the FCC Identifier specified above has been shown to comply with the applicable technical standards as indicated in the measurement report and has been tested in accordance with the measurement procedures specified in ANSI C63.4-2003 (See Test Report). These measurements were performed with no deviation from the standards.

I authorize and attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

PCTEST certifies that no party to this application has been denied the FCC benefits pursuant to Section 5301 of the Anti-Drug Abuse Act of 1988, 21 U.S.C. 862.


Randy Ortanez
President







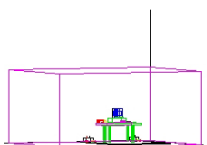
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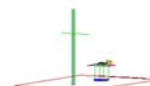
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MEASUREMENT REPORT

FCC Part 15.225



§ 2.1033 General Information



APPLICANT: En-Vision America, Inc.
APPLICANT ADDRESS: 1845 W. Hovey Ave.
 Normal, IL 61761
TEST SITE: PCTEST ENGINEERING LABORATORY, INC.
TEST SITE ADDRESS: 6660-B Dobbin Road, Columbia, MD 21045 USA
FCC RULE PART(S): Part 15 Subpart C (15.225)
MODEL: ScripTalk Station
FCC ID: VE3-STS1
Test Device Serial No.: N/A ☐ Production ☒ Pre-Production ☐ Engineering
FCC CLASSIFICATION: Part 15 Low Power Communication Device Transmitter (DXX)
DATE(S) OF TEST: July 28, 2007
TEST REPORT S/N: 0706150608.VE3

Test Facility / Accreditations

Measurements were performed at PCTEST Engineering Lab located in Columbia, MD 21045, U.S.A.



- PCTEST facility is an FCC registered (PCTEST Reg. No. 90864) test facility with the site description report on file and has met all the requirements specified in Section 2.948 of the FCC Rules and Industry Canada (IC-2451).
- PCTEST Lab is accredited to ISO 17025 by U.S. National Institute of Standards and Technology (NIST) under the National Voluntary Laboratory Accreditation Program (NVLAP Lab code: 100431-0) in EMC, FCC and Telecommunications.
- PCTEST Lab is accredited to ISO 17025-2005 by the American Association for Laboratory Accreditation (A2LA) in Specific Absorption Rate (SAR) testing, Hearing Aid Compatibility (HAC) testing, CTIA Test Plans, and wireless testing for FCC and Industry Canada Rules.
- PCTEST Lab is a recognized U.S. Conformity Assessment Body (CAB) in EMC and R&TTE (n.b. 0982) under the U.S.-EU Mutual Recognition Agreement (MRA).
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC Guide 65 by the American National Standards Institute (ANSI) in all scopes of FCC Rules and Industry Canada Standards (RSS).
- PCTEST facility is an IC registered (IC-2451) test laboratory with the site description on file at Industry Canada.
- PCTEST is a CTIA Authorized Test Laboratory (CATL) for AMPS, CDMA, and EvDO wireless devices and for Over-the-Air (OTA) Antenna Performance testing for AMPS, CDMA, GSM, GPRS, EGPRS, UMTS (W-CDMA), CDMA 1xEVDO, and CDMA 1xRTT.

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1.0 INTRODUCTION

1.1 Evaluation Procedure

The measurement procedure described in the American National Standard for Methods of Measurement of Radio-Noise Emission from Low-Voltage Electrical and Electronic Equipment in the Range of 9kHz to 40GHz (ANSI C63.4-2003) was used in the measurement of the **ScripTalkMax RFID Reader FCC ID: VE3-ST51**.

Deviation from measurement procedure.....None

1.2 Scope

Measurement and determination of electromagnetic emissions (EMC) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission.

1.3 PCTEST Test Location

The map at the right shows the location of the PCTEST LABORATORY, its proximity to the FCC Laboratory, the Columbia vicinity area, the Baltimore-Washington Intern't'l (BWI) airport, the city of Baltimore and the Washington, DC area. (see Figure 1-1).

These measurement tests were conducted at the PCTEST Engineering Laboratory, Inc. facility in New Concept Business Park, Guilford Industrial Park, Columbia, Maryland. The site address is 6660-B Dobbin Road, Columbia, MD 21045. The test site is one of the highest points in the Columbia area with an elevation of 390 feet above mean sea level. The site coordinates are 39° 11'15" N latitude and 76° 49'38" W longitude. The facility is 1.5 miles North of the FCC laboratory, and the ambient signal and ambient signal strength are approximately equal to those of the FCC laboratory. There are no FM or TV transmitters within 15 miles of the site. The detailed description of the measurement facility was found to be in compliance with the requirements of § 2.948 according to ANSI C63.4-2003 on January 27, 2006 and Industry Canada.

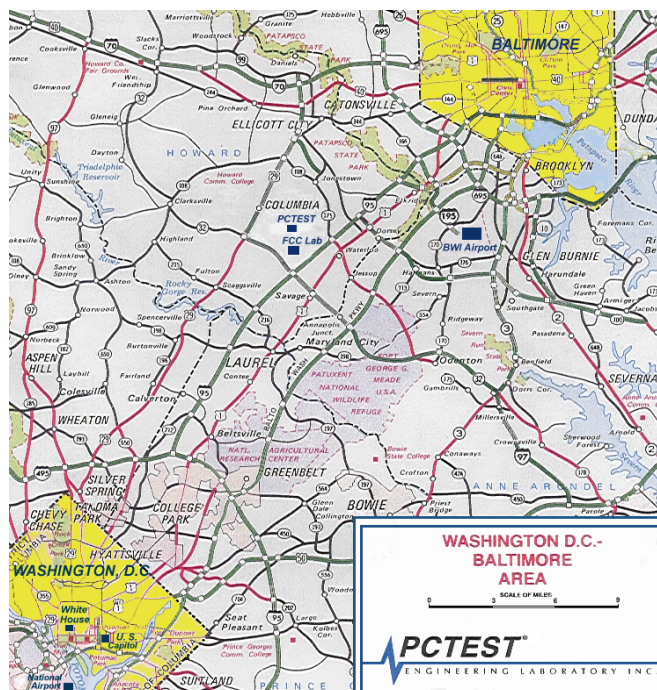




Figure 1-1. Map of the Greater Baltimore and Metropolitan Washington, D.C. area

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2.0 PRODUCT INFORMATION

2.1 Equipment Description

The Equipment Under Test (EUT) is the **ScripTalkMax RFID Reader FCC ID: VE3-STS1**. The test data contained in this report pertains to the RFID transmitter of the EUT.

Manufacturer / Model	FCC ID	Description
ScripTalkMax / Model: ScripTalk Station	VE3-STS1	RFID Reader
APX Technologies/Model: IB05U05VR	N/A	AC/DC Power Adapter

Table 2-1. EUT Equipment Description

2.2 Operation Mode

The En-Vision America, Inc. ScripTalk FCC ID: VE3-STS1 was set to continuously transmit at 13.56MHz. This was performed by placing a tag near the reader so continuous transmission would occur. Please see Section 7.0 for more information on the test setup.

2.3 EMI Suppression Device(s)/Modifications



A ferrite core (Fair-Rite P/N: 0431164281, or equivalent) with one loop was placed around the power adapter cable.

2.4 Labeling Requirements

Per 15.19; Docket 95-19

The label shall be permanently affixed at a conspicuous location on the device; instruction manual or pamphlet supplied to the user and be readily visible to the purchaser at the time of purchase. However, when the device is so small wherein placement of the label with specified statement is not practical, only the trade name and FCC ID must be displayed on the device per Section 15.19(b)(2).

Please see attachment for FCC ID label and label location.

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3.0 DESCRIPTION OF TEST

3.1 Conducted Emissions

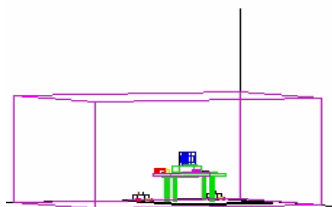


Figure 3-1. Shielded Enclosure Line-Conducted Test Facility

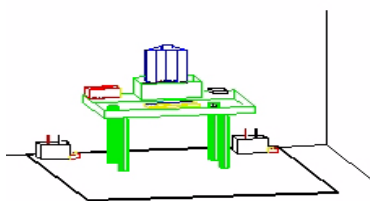


Figure 3-2. Line Conducted Emission Test Set-Up

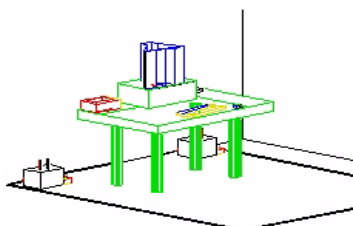


Figure 3-3. Wooden Table & Bonded LISNs

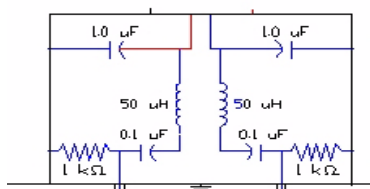




Figure 3-4. LISN Schematic Diagram

The line-conducted facility is located inside a 16'x20'x10' shielded enclosure, manufactured by Ray Proof Series 81 (see Figure 3-1). The shielding effectiveness of the shielded room is in accordance with MIL-Std-285 or NSA 65-5. A 1m x 1.5m wooden table 80cm high is placed 40cm away from the vertical wall and 1.5m away from the sidewall of the shielded room (see Figure 3-2). Solar Electronics and EMCO Model 3725/2 (10kHz-30MHz) 50Ω/50μH Line-Impedance Stabilization Networks (LISNs) are bonded to the shielded room (see Figure 3-3). The EUT is powered from the Solar LISN and the support equipment is powered from the EMCO LISN. Power to the LISNs are filtered by a high-current high-insertion loss Ray Proof power line filter (100dB 14Hz-10GHz). The purpose of the filter is to attenuate ambient signal interference and this filter is also bonded to the shielded enclosure. All electrical cables are shielded by braided tinned copper zipper tubing with an inner diameter of ½". If the EUT is a DC-powered device, power will be derived from the source power supply it normally will be powered from and this supply line(s) will be connected to the Solar LISN. The LISN schematic diagram is shown (see Figure 3-4). All interconnecting cables more than 1 meter were shortened to a 1 meter length by non-inductive bundling (serpentine fashion). Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The RF output of the LISN was connected to the spectrum analyzer to determine the frequency producing the maximum EME from the EUT.

The spectrum was scanned from 150kHz to 30MHz with a spectrum analyzer. The detector function was set to CISPR quasi-peak and average mode. The bandwidth of the analyzer was set to 10kHz. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each EME emission. Each emission was maximized by: switching power lines; varying the mode of operation or resolution; clock or data exchange speed; scrolling H pattern to the EUT and/or support equipment, and powering the monitor from the floor mounted outlet box and the computer aux AC outlet, if applicable; whichever determined the worst-case emission. Photographs of the worst-case emission can be seen in the test setup photographs. Each EME reported was calibrated using the Agilent E8257D (250kHz – 20GHz) PSG Signal Generator.

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3.2 Radiated Emissions

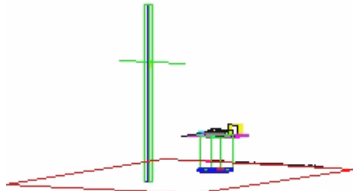


Figure 3-5. 3-Meter Test Site

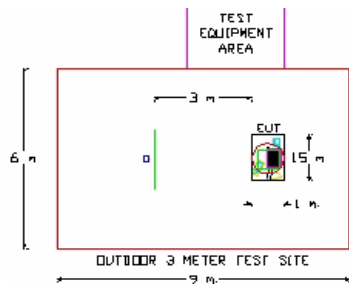


Figure 3-6. Dimensions of Outdoor Test Site

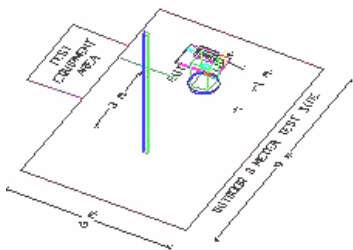


Figure 3-7. Turntable and System Setup

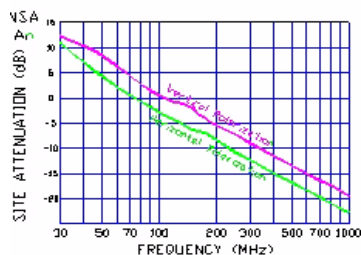




Figure 3-8. Normalized Site Attenuation Curves (H&V)

Preliminary measurements were made in a shielded anechoic chamber at 3-meter using broadband antennas, broadband amplifiers, and spectrum analyzers to determine the frequency producing the maximum EME. Appropriate precaution was taken to ensure that all EME from the EUT were maximized and investigated. The system configuration, clock speed, mode of operation or video resolution, and turntable azimuth with respect to the antenna was noted for each frequency found. The spectrum was scanned from 30 to 1000 MHz using a biconilog antenna. Above 1 GHz, linearly polarized double ridge horn antennas were used. For measurements below 30MHz a magnetic loop antenna was used.

Final measurements were made outdoors at 3-meter test range using Roberts™ Dipole antennas or horn antennas (see Figure 3-5) for above 30MHz and a loop antenna for below 30MHz. The test equipment was placed on a wooden and plastic bench situated on a 1.5m x 2m area adjacent to the measurement area (see Figure 3-6). Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The detector function was set to CISPR quasi-peak mode and the bandwidth of the spectrum analyzer was set to 100kHz for frequencies below 1GHz or 1MHz for frequencies above 1GHz. Above 1GHz the detector function was set to average mode (RBW = 1MHz, VBW = 10Hz). Emissions below 30MHz were made with a RBW of 10kHz and a VBW of 10Hz.

The half-wave dipole antenna was tuned to the frequency found during preliminary radiated measurements. The EUT, support equipment and interconnecting cables were re-configured to the set-up producing the maximum emission for the frequency and were placed on top of a 0.8-meter high non-metallic 1 x 1.5 meter table (see Figure 3-7). The EUT, support equipment, and interconnecting cables were re-arranged and manipulated to maximize each EME emission. The turntable containing the system was rotated and the height of the receive antenna was varied 1 to 4 meters and stopped at the azimuth and height producing the maximum emission. Each emission was maximized by: varying the mode of operation or resolution; clock or data exchange speed; scrolling H pattern to the EUT and/or support equipment, and powering the monitor from the floor mounted outlet box and the computer aux AC outlet, if applicable; and changing the polarity of the antenna, whichever determined the worst-case emission. Photographs of the worst-case emission can be seen in the test setup photographs. Each EME reported was calibrated using the Agilent E8257D (250kHz – 20GHz) PSG Signal Generator. The Theoretical Normalized Site Attenuation Curves for both horizontal and vertical polarization are shown in Figure 3-8.

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4.0 SAMPLE CALCULATIONS

4.1 Conducted Emission Measurement Sample Calculation

@ 20.3 MHz

Class B limit = 60.0 dB μ V (Quasi-peak limit)
Reading = - 57.8 dBm (calibrated quasi-peak level)
Convert to dB μ V = - 57.8 + 107 = 49.2 dB μ V

Margin = 49.2 - 60.0 = - 10.8 dB
= 10.8 dB below limit

4.2 Radiated Emission Measurement Sample Calculation



@ 66.7 MHz

Class B limit = 100 μ V/m = 40.0 dB μ V/m
Reading = - 76.0 dBm (calibrated level)
Convert to dB μ V = - 76.0 + 107 = 31.0 dB μ V
Antenna Factor + Cable Loss = 5.8 dB/m
Total = 36.8 dB μ V/m

Margin = 36.8 - 40.0 = - 3.2 dB
= 3.2 dB below limit

Note:

Level [dB μ V] = 20 log₁₀ (Level [μ V/m])
Level [dB μ V] = Level [dBm] + 107



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5.0 TEST EQUIPMENT CALIBRATION DATA

Test Equipment Calibration is traceable to the National Institute of Standards and Technology (NIST).

Manufacturer	Model / Equipment	Calibration Date	Cal Interval	Calibration Due	Serial No.
Agilent	E4407B ESA Spectrum Analyzer	04/29/07	Annual	04/28/08	US39210313
Agilent	HP 8566B (100Hz–22GHz) Spectrum Analyzer	12/21/06	Annual	12/21/07	3638A08713
Agilent	HP 8591A (9kHz-1.8GHz) Spectrum Analyzer	09/20/06	Annual	09/20/07	3144A02458
Agilent	HP 8591A (9kHz-1.8GHz) Spectrum Analyzer	09/20/06	Annual	09/20/07	3108A02053, 3034A01395
Agilent	E8257D (250kHz-20GHz) Signal Generator	03/08/07	Annual	03/07/08	MY45470194
CCA-7	CISPR QP Adapter	12/21/06	Annual	12/21/07	0194-04082
CCA-7	CISPR QP Adapter	12/21/06	Annual	12/21/07	0194-04082
Agilent	HP 85650A Quasi-Peak Adapter	12/21/06	Annual	12/21/07	2043A00301
Agilent	HP 8449B (1-26.5GHz) Pre-Amplifier	12/12/06	Annual	12/12/07	3008A00985
EMCO	Loop Antenna	09/23/06	Annual	09/23/07	N/A
Agilent	HP 85685A (20Hz-2GHz) Preselector	12/12/06	Annual	12/12/07	N/A
Agilent	HP 8566B Opt. 462 Impulse Bandwidth	12/12/06	Annual	12/12/07	3701A22204
Compliance Design	A100 Roberts Dipoles	08/31/05	Biennial	08/31/07	5118
EMCO	Dipole Pair	09/21/06	Biennial	09/20/08	23951
SOLAR	8012-50 LISN (2)	11/18/05	Biennial	11/18/07	0313233, 0310234
Pasternack	PE7000-6 6 dB Attenuator	N/A		N/A	N/A
Rohde & Schwarz	NRV-Z33 Peak Power Sensor (1mW-20W)	11/28/06	Biennial	11/27/08	100155
Rohde & Schwarz	NRV-Z32 Peak Power Sensor (100uW-2W)	12/21/06	Biennial	12/20/08	100004
EMCO	3116 Horn Antenna (18 - 40GHz)	09/25/05	Biennial	09/25/07	9203-2178

Table 5-1. Annual Test Equipment Calibration Schedule



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6.0 ENVIRONMENTAL CONDITIONS

The temperature is controlled within range of 15°C to 35°C.

The relative humidity is controlled within range of 10% to 75%.

The atmospheric pressure is controlled within the range 86-106kPa (860-1060mbar).

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7.0 TEST DATA

7.1 Summary

Company Name: En-Vision America, Inc.
 FCC ID: VE3-STS1
 Frequencies Examined: 13.56MHz

FCC Part Section(s)	Test Description	Test Limit	Test Condition	Test Result	Reference
TRANSMITTER MODE (Tx)					
2.1049	20dB Bandwidth	13.11 – 14.01 MHz	RADIATED	Pass	Section 7.2
15.225 (a)	In-Band Emissions	15,848µV/m @ 30m 13.553 – 13.567 MHz		Pass	Section 7.3
15.225 (b)	In-Band Emissions	334µV/m @ 30m 13.410 – 13.553 MHz 13.567 – 13.710 MHz		Pass	Section 7.3
15.225 (c)	In-Band Emissions	106µV/m @ 30m 13.110 – 13.410 MHz 13.710 – 14.010 MHz		Pass	Section 7.3
15.225 (d) 15.209	Out-of-Band Emissions	Emissions outside of the specified band (13.110 – 14.010 MHz) must meet the radiated limits detailed in 15.209		Pass	Section 7.4
15.207	AC Conducted Emissions 150kHz – 30MHz	< FCC 15.207 limits or < RSS-Gen table 2 limits	LINE CONDUCTED	Pass	Section 7.5
15.225(e)	Frequency Stability	+/-0.01% of operating frequency	RADIATED	Pass	Section 7.6
RECEIVER MODE (Rx) / DIGITAL DEVICE					
15.107	AC Conducted Emissions 150kHz – 30MHz	< FCC 15.107 limits or < RSS-Gen table 2 limits	LINE CONDUCTED	Pass	Part 15B Test Report
15.109	General Field Strength Limits (Restricted Bands and Radiated Emissions Limits)	< FCC 15.109 limits or < RSS-Gen limits [Section 6; Table1]	RADIATED (30MHz-1GHz) (1-25 GHz)	Pass	Part 15B Test Report

Table 7-1 Summary of Test Results

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7.2 20dB Bandwidth Measurement

\$2.1049

The 20dB bandwidth is measured with a spectrum analyzer connected via a receive antenna placed near the EUT while the EUT is operating in transmission mode.

Frequency	Occupied Bandwidth
13.56MHz	145 kHz

Table 7-2. 20dB Bandwidth Measurement

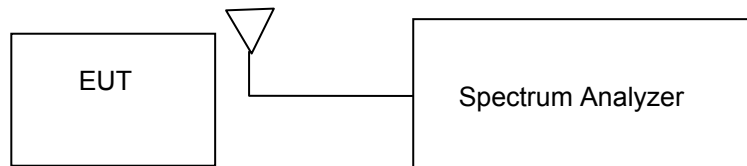


Figure 7-1. Test Instrument & Measurement Setup

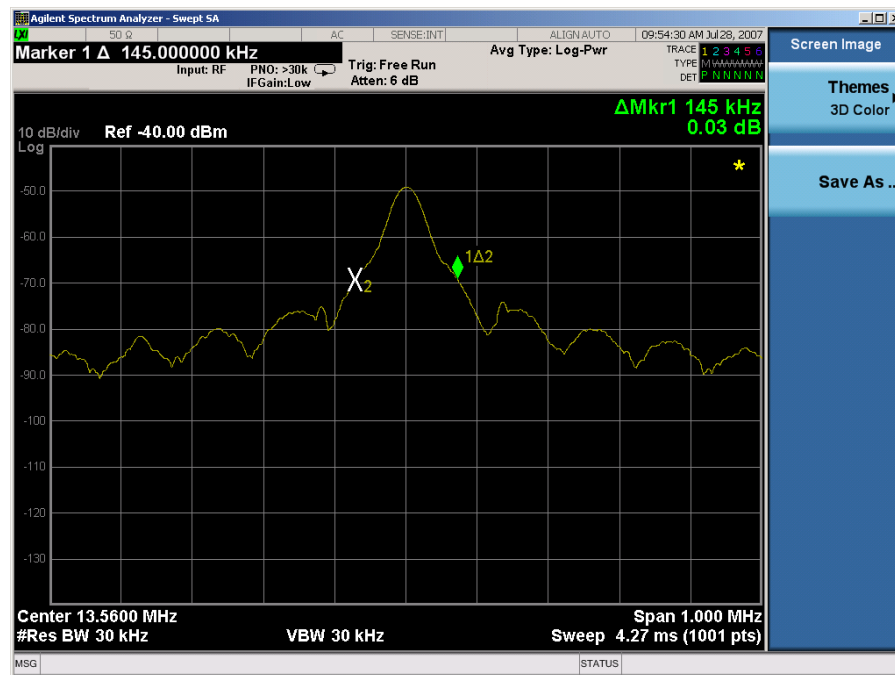




Figure 7-2. Occupied Bandwidth Plot

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7.3 In-Band Radiated Spurious Emission Measurements §15.225(a), (b), (c)

Radiated emissions testing was performed in the band 13.110 – 14.010 MHz.

Frequency: 13.56MHz

Measurement Distance: 3 Meters

Fundamental at 13.56MHz										
FREQ [MHz]	LEVEL [dBm]	AFCL [dBm]	Antenna Position	Azimuth [Degree]	3m Field Strength [dBµV/m]	Field Strength [µV/m]	Distance Correction [3 to 30m] [dBµV/m]	Limit [µV/m]	Limit [dBµV/m]	Margin [dB]
13.5605	-43.24	10.34	X	0	74.1	5069.91	34.10	15848.00	84.00	-49.90
13.553	-49.03	10.34	X	0	68.3	2603.15	28.31	334.00	50.47	-22.16
13.567	-48.6	10.34	X	0	68.7	2735.27	28.74	334.00	50.47	-21.73
13.385	-75.86	10.34	X	0	41.5	118.58	1.48	106.00	40.51	-39.03
13.721	-74.58	10.34	X	0	42.8	137.40	2.76	106.00	40.51	-37.75



Table 7-3. In-Band Radiated Measurements

NOTES:

1. All measurements were performed using a loop antenna. The antenna was positioned in three orthogonal positions (X front, Y side, Z top) and the position with the highest emission level was recorded.
2. Measurements were performed at 3m and the data was extrapolated to the specified measurement distance of 30m using the square of an inverse linear distance extrapolation factor (40 dB/decade) as specified in §15.31(f)(2).

$$\text{Extrapolation Factor} = 20 \times \text{LOG}(30/3)^2 = 40\text{dB}$$

3. All measurements were recorded using a spectrum analyzer employing an average detector.
4. The EUT is supplied with nominal AC voltage.

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7.4 Radiated Spurious Emission Measurements, Out-of-Band

§15.225(d) / §15.209

The EUT was tested from 9kHz up to the 1GHz excluding the band 13.110 – 14.010 MHz. All measurements were recorded with a spectrum analyzer employing an average detector for emissions below 30MHz. Above 30MHz a Quasi-peak detector was used. All out-of-band emissions must not exceed the limits shown in Table 7-4 per Section 15.209. A loop antenna was used for searching for emissions below 30MHz.

Frequency	Field Strength [μV/m]	Measured Distance [Meters]
0.009 – 0.490 MHz	2400/F (kHz)	300
0.490 – 1.705 MHz	24000/F (kHz)	30
1.705 – 30.00 MHz	30	30
30.00 – 88.00 MHz	100	3
88.00 – 216.0 MHz	150	3
216.0 – 960.0 MHz	200	3
Above 960.0 MHz	500	3



Table 7-4. Radiated Limits – Out of band

Sample Calculation

- Field Strength Level $_{[dB\mu V/m]} = \text{Analyzer Level}_{[dBm]} + 107 + \text{AFCL}_{[dB]} + \text{Duty Cycle Correction}_{[dB]}$

Notes:

- AFCL = Antenna Factor $_{[dB]} + \text{Cable Loss}_{[dB]}$

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Radiated Spurious Emission Measurements, Out-of-Band (Cont'd)

§15.225(d) / §15.209

Tx Frequency 13.56MHz



Measurement Distance: 3 Meters

FREQ [MHz]	LEVEL [dBm]	Antenna Factor [dBm]	Cable Loss [dBm]	AFCL [dBm]	POL [H/V]	Azimuth [Degree]	Field Strength [dB μ V/m]	Field Strength [μ V/m]	Limit [μ V/m]	Limit [dB μ V/m]	Margin [dB]
81.36	-84.8	10.03	1.47	11.50	H	86	33.7	48.43	100.00	40.000	-6.3
94.92	-91.0	10.46	1.59	12.05	H	76	28.0	25.25	150.00	43.522	-15.5
108.48	-84.8	11.06	1.71	12.77	H	0	35.0	56.05	150.00	43.522	-8.6
122.05	-84.6	11.73	1.83	13.56	H	0	36.0	62.77	150.00	43.522	-7.6
135.60	-81.8	12.33	1.93	14.26	H	50	39.5	93.93	150.00	43.522	-4.1
149.20	-81.6	12.87	2.02	14.89	H	60	40.3	103.42	150.00	43.522	-3.2
162.85	-82.7	12.93	2.11	15.04	H	0	39.3	92.65	150.00	43.522	-4.2
257.64	-78.4	12.45	2.68	15.13	H	220	43.7	153.59	200.00	46.021	-2.3
488.30	-85.8	18.01	3.62	21.63	H	220	42.8	138.52	200.00	46.021	-3.2
542.40	-87.1	18.87	3.80	22.67	H	220	42.6	134.46	200.00	46.021	-3.4

Table 7-5. Radiated Measurements

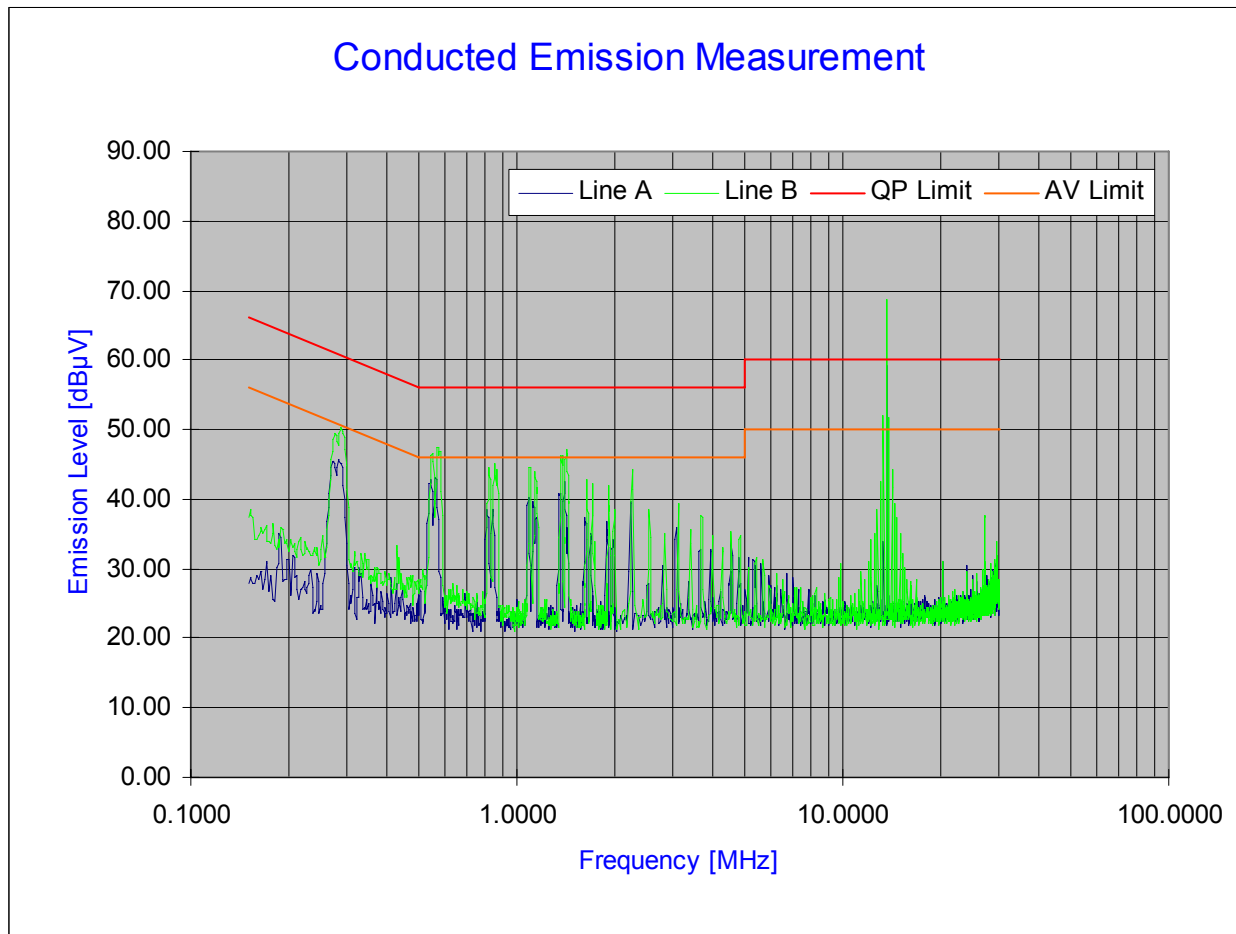
NOTES:

1. All measurements were recorded using a spectrum analyzer employing an average detector for below 30MHz and a Quasi-peak detector for above 30 MHz.
2. Both Vertical and Horizontal polarities of the receive antenna were evaluated with the worst case emissions being reported. Below 30MHz the Loop antenna was positioned in 3 separate radials.
3. The EUT is supplied with nominal AC voltage and/or a new/fully-recharged battery.
4. The spectrum is measured from 9kHz to the 10th harmonic and the worst-case emissions are reported.

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7.5 Line Conducted Measurement Data



§15.207; RSS-Gen (7.2.2)



Plot 7-1. Line-Conducted Test Plot

Notes:

1. All Modes of operation were investigated and the worst-case emissions are reported.
2. The limit for Class B device(s) from 150kHz to 30MHz are specified in Section 15.207 of the Title 47 CFR.
3. Line A = Phase; Line B = Neutral
4. Traces shown in plot are made using a peak detector.
5. Deviations to the Specifications: None.

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Line Conducted Measurement Data (Cont'd)

§15.207; RSS-Gen (7.2.2)

Company : **Envision**
 Model Number : **Scriptalk**
 Standard : **FCC Part 15C, 15.207**



Power Source : **AC120V/60Hz**
 Tested Date : **07/28/2007**
 Test Engineer : **Greg Snyder**

No.	Line	Frequency [MHz]	Factor [dB]	QP [dBμV]	Limit [dBμV]	Margin [dB]	Average [dBμV]	Limit [dBμV]	Margin [dB]
1	A	0.282	7.64	44.84	60.77	-15.93	33.94	50.77	-16.83
2	A	0.285	7.62	44.46	60.66	-16.20	33.17	50.66	-17.49
3	A	0.541	7.42	38.22	56.00	-17.78	26.70	46.00	-19.30
4	A	0.563	7.41	41.81	56.00	-14.19	29.68	46.00	-16.32
5	A	1.081	7.31	34.87	56.00	-21.13	21.48	46.00	-24.52
6	A	1.122	7.31	38.14	56.00	-17.86	27.20	46.00	-18.80
7	A	1.356	7.34	36.90	56.00	-19.10	21.60	46.00	-24.40
8	A	1.398	7.34	40.95	56.00	-15.05	29.70	46.00	-16.30
9	A	2.239	7.41	38.80	56.00	-17.20	26.61	46.00	-19.39
10	A	13.563	7.81	57.74	60.00	-2.26	36.39	50.00	-13.61
11	B	0.285	7.63	50.03	60.68	-10.65	43.34	50.68	-7.34
12	B	0.535	7.42	43.47	56.00	-12.53	27.82	46.00	-18.18
13	B	0.567	7.41	46.76	56.00	-9.24	39.48	46.00	-6.52
14	B	0.847	7.35	43.89	56.00	-12.11	34.75	46.00	-11.25
15	B	1.088	7.31	41.08	56.00	-14.92	23.13	46.00	-22.87
16	B	1.360	7.34	42.99	56.00	-13.01	25.28	46.00	-20.72
17	B	1.423	7.35	39.32	56.00	-16.68	21.08	46.00	-24.92
18	B	13.295	7.79	46.58	60.00	-13.42	24.07	50.00	-25.93
19	B	13.563	7.81	58.56	60.00	-1.44	47.03	50.00	-2.97
20	B	13.836	7.82	45.62	60.00	-14.38	26.61	50.00	-23.39

Table 7-6. Line-Conducted Test Data

Notes:

1. All Modes of operation were investigated and the worst-case emissions are reported.
2. The limit for Class B device(s) from 150kHz to 30MHz are specified in Section 15.207 of the Title 47 CFR.
3. Line A = Phase; Line B = Neutral
4. Traces shown in plot are made using a peak detector.
5. Deviations to the Specifications: None.

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7.6 Frequency Stability Test Data

§15.225

Part 15.225 requires that devices operating in the 13.553 – 13.567 MHz shall maintain the carrier frequency within 0.01% of the operating frequency over the temperature variation of –20 degrees to +50 degrees C at normal supply voltage, and for a variation in the primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 degrees C.

FREQUENCY STABILITY, FCC PART 15.225



OPERATING FREQUENCY: 13,560,500 Hz

REFERENCE VOLTAGE: 120 Vac

DEVIATION LIMIT: ± 0.01 % = 1356Hz

VOLTAGE (%)	POWER (Vac)	TEMP (°C)	FREQ. (Hz)	Freq. Dev. (Hz)	Deviation (%)
100 %	120.00	+ 20 (Ref)	13,560,511	11	0.000081
100 %		- 30	13,560,545	45	0.000332
100 %		- 20	13,560,477	-23	-0.000170
100 %		- 10	13,560,457	-43	-0.000317
100 %		0	13,560,478	-22	-0.000162
100 %		+ 10	13,560,518	18	0.000133
100 %		+ 20	13,560,531	31	0.000229
100 %		+ 25	13,560,494	-6	-0.000044
100 %		+ 30	13,560,486	-14	-0.000103
100 %		+ 40	13,560,518	18	0.000133
100 %		+ 50	13,560,510	10	0.000074
85 %	102.00	+ 20	13,560,508	8	0.000059
115 %	138.00	+ 20	13,560,515	15	0.000111

Table 7-7. Frequency Stability Test Data

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FREQUENCY STABILITY FCC PART 15.225

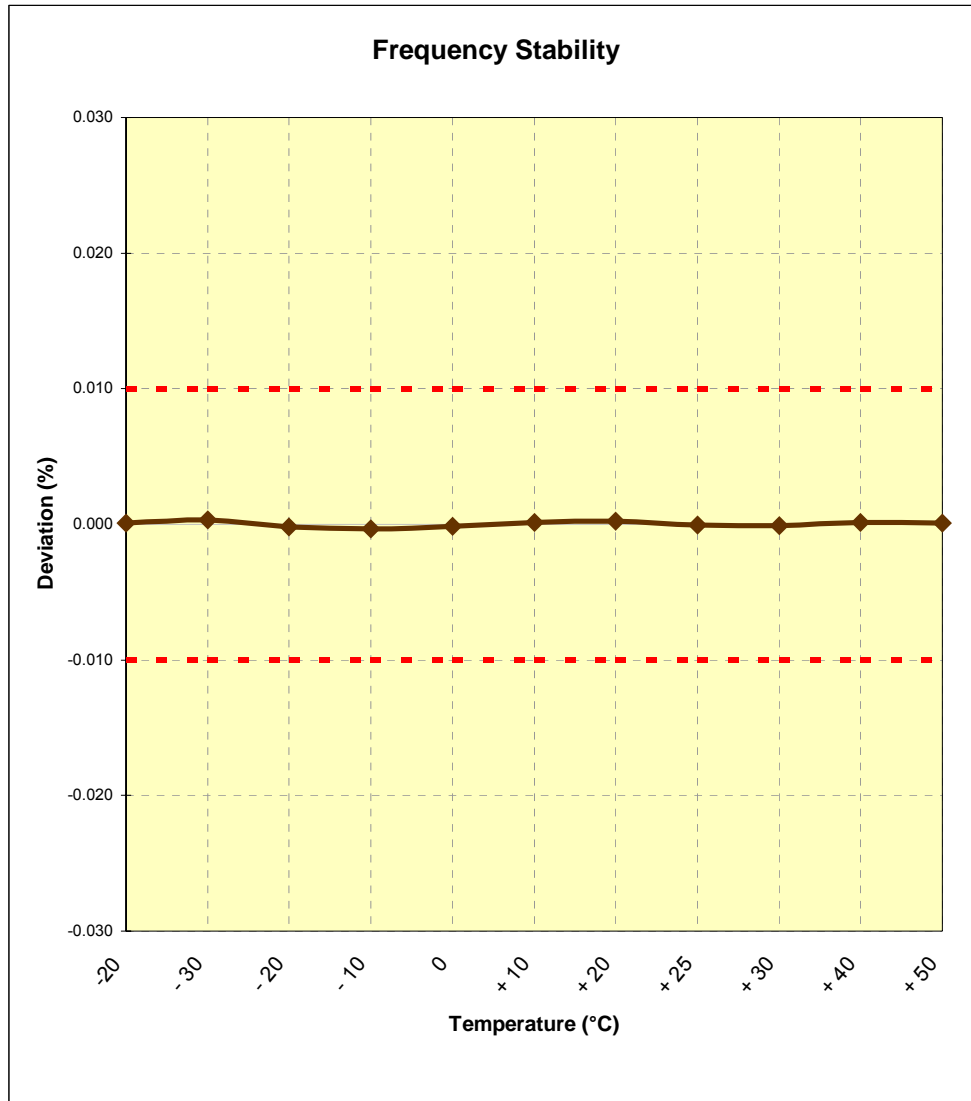






Figure 7-3. Frequency Stability Plot

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8.0 CONCLUSION

The data collected relate only to the item(s) tested and show that the **ScripTalkMax RFID Reader**
FCC ID: VE3-STS1 has been tested to comply with the requirements specified in §15.225 of the FCC Rules.

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